

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/511,170	KOJIMA ET AL.
Examiner	Art Unit	
John D. Lee	2874	

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
359	326-332	8/30/2006	JDL
372	21-22	8/30/2006	JDL